Application/Control No. Applicant(s)/Patent Under Reexamination 10/080,121 WAKISAKA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2828 Quyen P. Leung **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-4,338,577 07-1982 Sato et al. 372/36 Α 372/36 В US-6,219,364 04-2001 Dei, Yoshihiro * С US-6,359,330 03-2002 Goudard, Jean-Luc 257/678 D US-US-E F US-US-G US-Н ١ US-J US-US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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